Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	er
10/796,194	SATOH ET AL.	
Examiner	Art Unit	
Ren L. Yan	2854	

	SEAR	CHED	
Class	Subclass	Date	Examiner
101	116	10/10/06	RY
	118		
	232		
271	10.01		
	10.03		
	110		
	111		
	258.0	1	
	259		
	265.01		
	265.02	,	
-			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
		. 	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
•		
		<u> </u>
	A	
	·	
		1
		10